

PC905

Long Creepage Distance Photocoupler with Built-in Voltage Detection Circuit

※ Lead forming type (I type) is also available. (PC905I) (Page 656)

※※ TUV (DIN -VDE0884) approved type is also available as an option.

■ Features

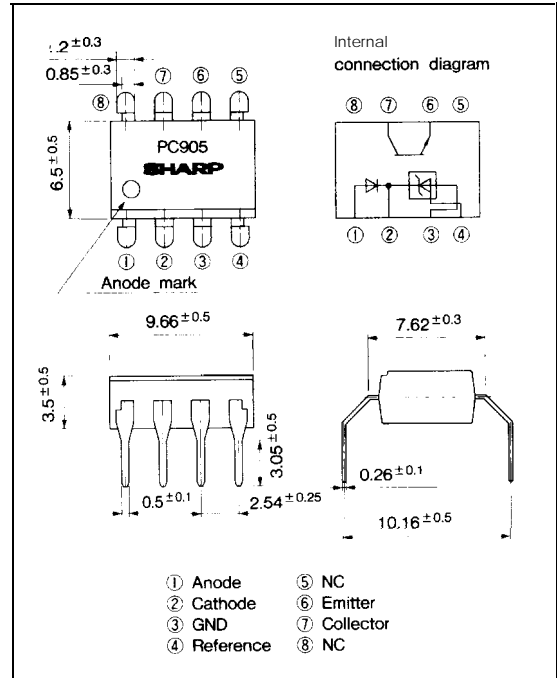
1. Built-in voltage deviation detection circuit
2. Long creepage distance type
(Creepage distance :8mm or more)
3. Conforms to European Safety Standard
(Internal insulation distance :0.5mm or more)
4. High collector-emitter voltage (V_{CEO} : 70V)
5. High isolation voltage between input and output (V_{iso} : 5 000V_{rms})
6. Recognized by UL, file No. E64380
Approved by BSI(BS415:No. 6990, BS7002:No. 7567)
Approved by SEMKO No. 8907261
Approved by DEMKO No. 392592

■ Applications

1. Switching power supplies

■ Outline Dimensions

(Unit : mm)



■ Absolute Maximum Ratings

($T_a = 25^\circ\text{C}$)

	Parameter	Symbol	Rating	Unit
Input	Anode current	I_A	50	mA
	Anode voltage	V_A	30	v
	Reference input current	I_{REF}	10	mA
	Power dissipation	P	250	mW
output	Collector -emitter voltage	V_{CEO}	70	v
	Emitter -collector voltage	V_{ECO}	6	v
	Collector current	I_C	50	mA
	Collector power dissipation	P_C	150	mW
	Total power dissipation	P_{tot}	350	mW
	*1 Isolation voltage	vi."	5000	V _{rms}
	Operating temperature	T_{opr}	-25 to +85	°C
	Storage temperature	T_{stg}	-40 to + 125	°C
	*2 Soldering temperature	T_{sol}	260	°C

*1 40 to 60%RH, AC for 1 minute

*2 For 10 seconds

■ Electro-optical Characteristics

(Ta = 25°C unless otherwise specified.)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX	Unit	Fig.
Input	Reference voltage	V_{REF}	$V_K = V_{REF}, I_A = 10mA$	2.40	2.495	2.60	V	1
	*3 Temperature change in reference voltage	$V_{REF(dev)}$	$V_K = V_{REF}, I_A = 10mA, Ta = -25 \text{ to } +85^\circ C$	—	8	40	mV	1
	Voltage variation ratio in reference voltage	$\Delta V_{REF}/\Delta V_i$	$I_A = 10mA, \Delta V_A = 30V - V_{REF}$	—	-1.4	-5	mV/V	2
	Reference input current	I_{REF}	$I_A = 10mA, R_3 = 10k\Omega$	—	2	10	μA	3
	*4 Temperature change in reference input current	$I_{REF(dev)}$	$I_A = 10mA, R_3 = 10k\Omega, Ta = -25 \text{ to } +85^\circ C$	—	0.4	3	μA	3
	Minimum drive current	I_{MIN}	$V_K = V_{REF}$	—	1	2	mA	1
	OFF-state anode current	I_{OFF}	$V_A = 30V, V_{REF} = GND$	—	0.1	2	μA	4
output	Anode-cathode forward voltage	V_F	$V_K = V_{REF}, I_A = 10mA$	—	1.2	1.4	V	1
	Collector dark current	I_{CEO}	$V_{CE} = 20V$	—	10^{-9}	10^{-7}	A	5
	*5 Current transfer ratio	CTR	$V_K = V_{REF}, I_b = 10I_{IL4}, V_{CE} = 5V$	40	—	320	%	6
	Collector -emitter saturation voltage	$V_{CE(sat)}$	$V_K = V_{REF}, I_A = 20mA, I_C = 1mA$	—	0.1	0.2	V	6
Transfer characteristics	Isolation resistance	R_{ISO}	40 to 60%RH, DC500V	1×10^{10}	$\times 10^{11}$	—	Ω	—
	Floating capacitance	C_f	$V=0, f=1MHz$	—	0.6	1.0	pF	—

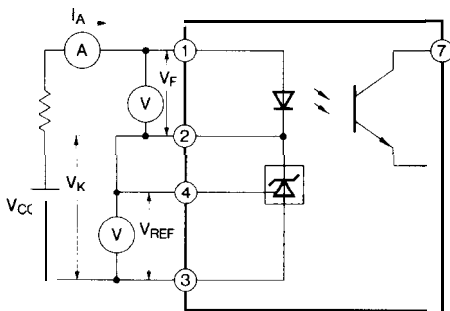
*3 $V_{REF(dev)} = V_{REF(MAX)} - V_{REF(MIN)}$

*4 $I_{REF(dev)} = I_{REF(MAX)} - I_{REF(MIN)}$

*5 $CTR = I_c/I_b \times 100(\%)$

■ Test Circuit

Fig. 1



V_K : Voltage between terminals ② and ③

V_{REF} : Voltage between terminals ③, and ④

Fig. 2

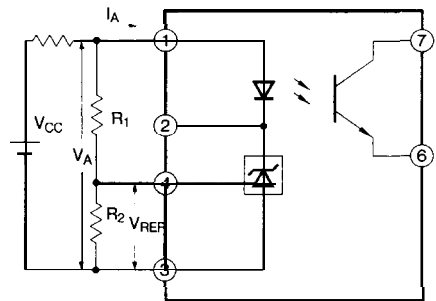


Fig. 3

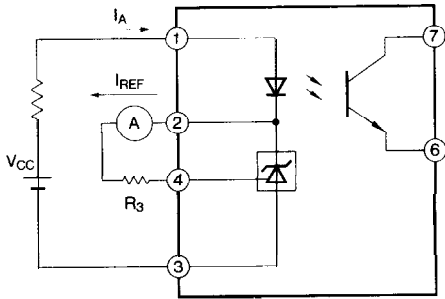


Fig. 4

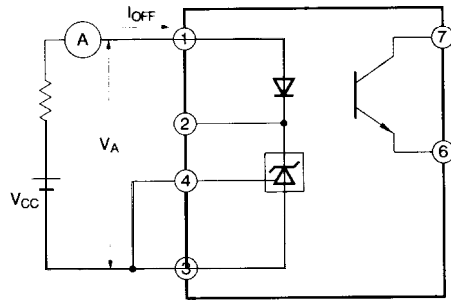


Fig. 5

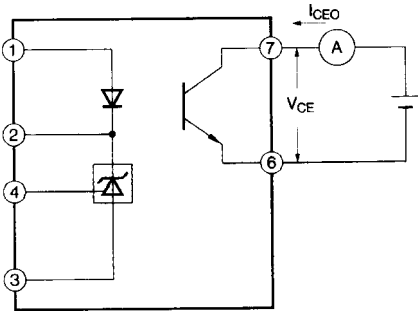


Fig. 6

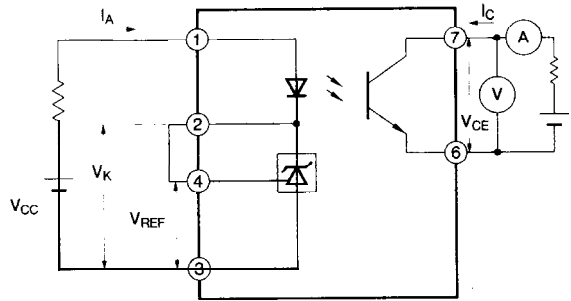


Fig. 7 Anode Current vs. Ambient Temperature

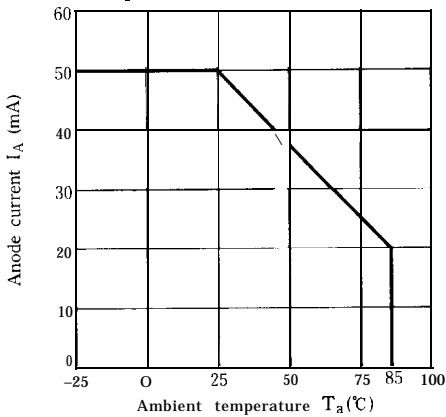


Fig. 8 Input Power Dissipation vs. Ambient Temperature

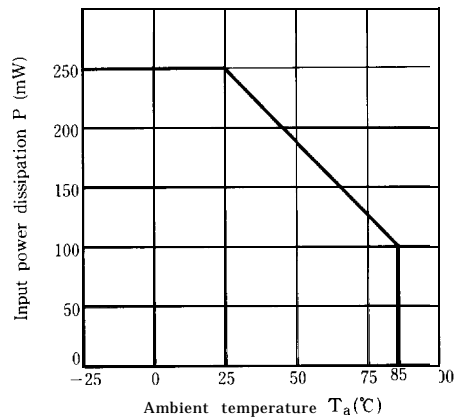


Fig. 9 Collector Power Dissipation vs. Ambient Temperature

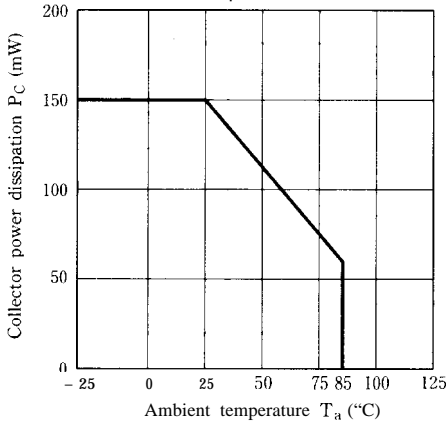


Fig.10 Power Dissipation vs. Ambient Temperature

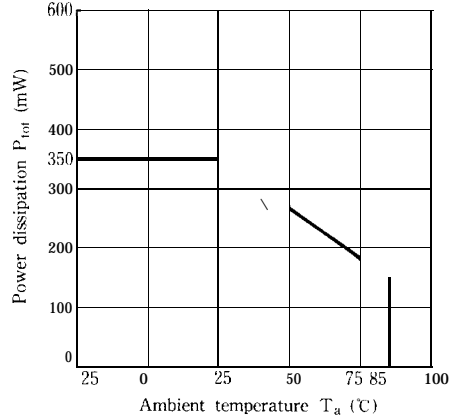


Fig.11 Relative Current Transfer Ratio vs. Ambient Temperature

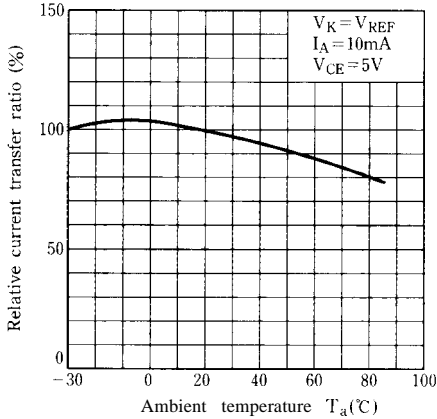


Fig.12 Collector Dark Current vs. Ambient Temperature

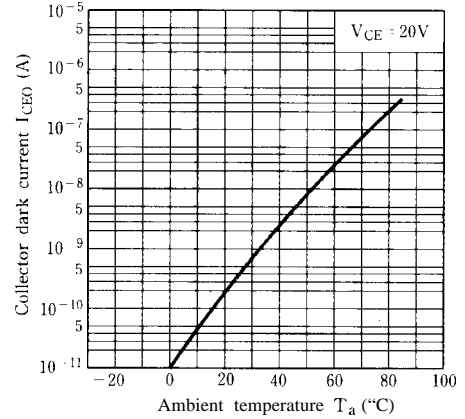


Fig.13-a Anode Current vs. Reference Voltage

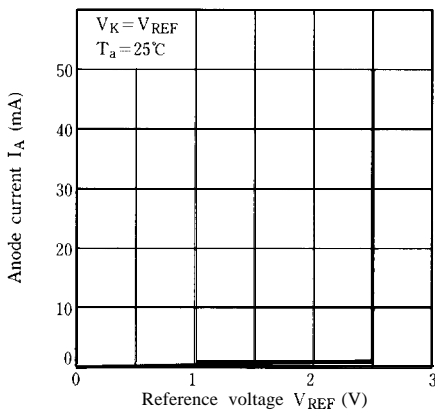


Fig.13-b Anode Current vs. Reference Voltage

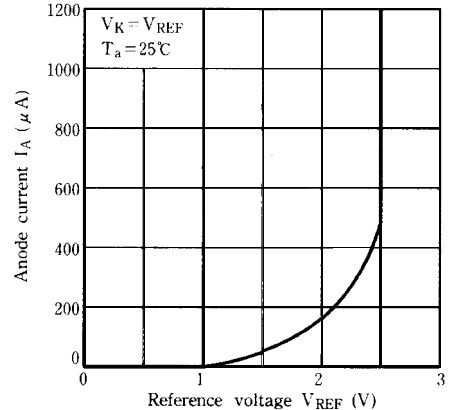


Fig.14 OFF-stats Anode Current vs. Ambient Temperature

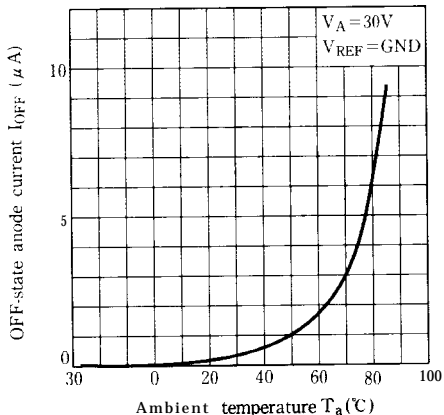


Fig.16 Reference Input Current vs. Ambient Temperature

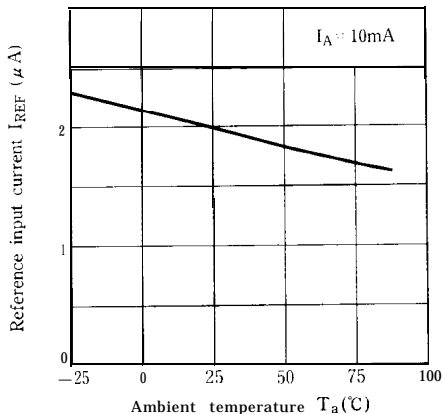


Fig.18-a Voltage Gain (1) vs. Frequency

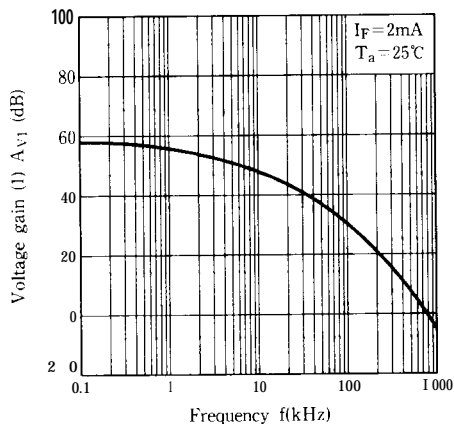


Fig.15 Reference Voltage Change vs. Ambient Temperature

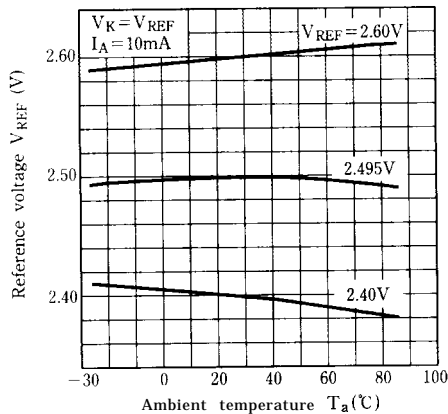
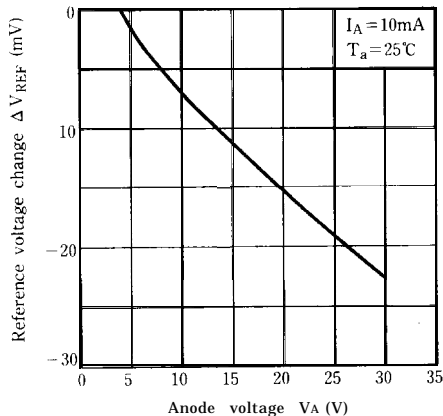


Fig.17 Reference Voltage Change vs. Anode Voltage



Test Circuit for Voltage Gain (1) vs. Frequency

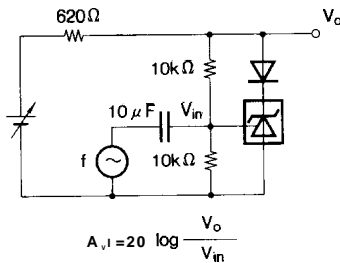
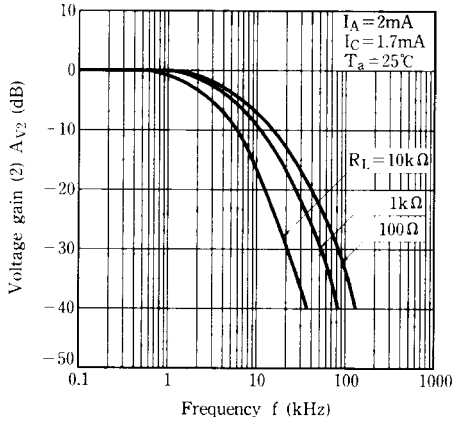


Fig.18-b Voltage Gain (2) vs. Frequency



Test Circuit for Voltage Gain (2) vs. Frequency

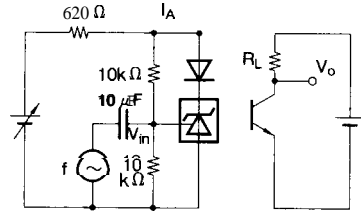
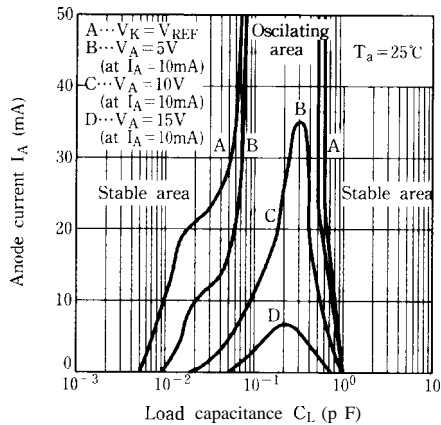


Fig.19 Anode Current vs. Load Capacitance



Test Circuit for Anode Current vs. Load Capacitance

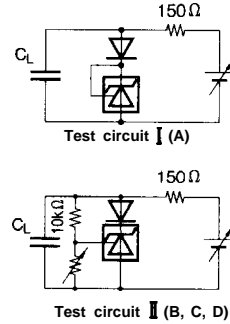


Fig.20 Collector-emitter Saturation voltage vs. Ambient Temperature

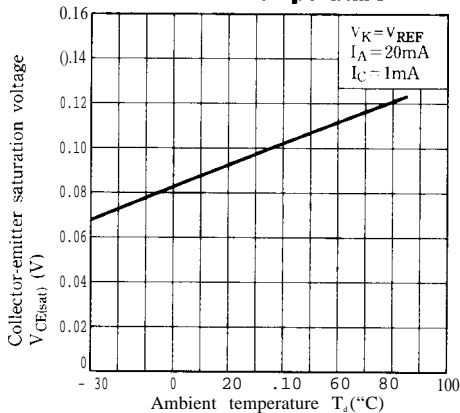
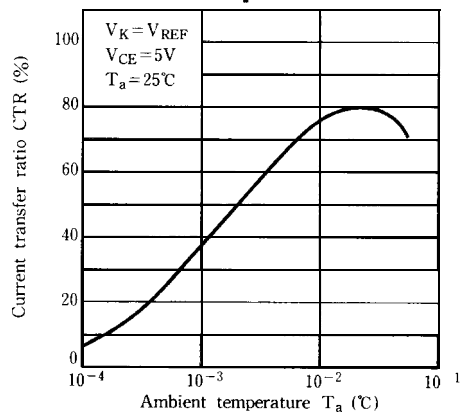


Fig.21 Current Transfer Ratio vs. Ambient Temperature



■ Precautions for Use

Handle this product the same as with other integrated circuits against static electricity.

- As for other general cautions, refer to the chapter "Precautions for Use" (Page 78 to 93).